Search Notes

Application/Control No.	Applicant(s Reexamina
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Applicant(s)/Patent under Reexamination YAMANO, AKIRA

09/995,770 Examiner

Art Unit 2625

. Vu B. Hang

	SEAR	CHED	
Class	Subclass	Date	Examiner
358	1.15	11/30/2006	V.H.
358	1.14	11/30/2006	V.H.
358	1.13	11/30/2006	٧,μ.
358	406	11/30/2006	V.H.
358	448	11/30/2006	V.A.
358	475	11/30/2006	N.L.
347	112	11/30/2006	V.H.
347	115	11/30/2006	V.U.
347	129	11/30/2006	V.H.
347	132	11/30/2006	v. H.
347	133	11/30/2006	4.4
355	40	11/30/2006	V.H.

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
358	1.13	11/30/2006	٧,١	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE EXMI	R	
UpdatedEAST Search	11/29/2006 V.H.		
Interference Search	11/29/2006 V.H.	,	
Inventor Search	11/30/2006 V.H	- !.	
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